

# APPROVAL SHEET

MULTILAYER CERAMIC CAPACITORS

Ultra-small Series (6.3V to 50V)

01005 Size

NP0, X7R & X5R Dielectrics

Halogen Free & RoHS Compliance

\*Contents in this sheet are subject to change without prior notice.





Approval Sheet

# 1. INTRODUCTION

MLCC consists of a conducting material and electrodes. To manufacture a chip-type SMT and achieve miniaturization, high density and high efficiency, ceramic condensers are used.

01R5 MLCC is performed by high precision technology achieve high capacitance in unit size and ensure the stability and reliability of products.

# 2. FEATURES

- a. High capacitance in unit size.
- b. High precision dimensional tolerances.
- c. Suitable used in high-accuracy automatic mounting machine.

# 3. APPLICATIONS

- a. Miniature microwave module.
- b. Portable equipments (ex. Mobile phone, PDA).
- c. High frequency circuits.

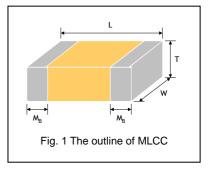
# **4. HOW TO ORDER**

| <u>01R5</u>                   | <u>N</u>                                | <u>100</u>  | <u>C</u>   | <u>160</u>  | <u>C</u>           | I                   |
|-------------------------------|---|---|--|---|--------------------|---------------------|
| <u>Size</u>                   | Dielectric                              | <u>Capacitance</u>  | <u>Tolerance</u>   | Rated voltage   | <u>Termination</u> | <u>Packaging</u>    |
| Inch (mm) 01R5 = 01005 (0402) | <b>N</b> =NP0<br>(C0G)<br><b>B</b> =X7R | Two significant digits followed by no. of zeros. And R is in place of | <b>A</b> =±0.05pF<br><b>B</b> =±0.1pF<br><b>C</b> =±0.25pF | Two significant digits followed by no. of zeros. And R is in    | <b>C</b> =Cu/Ni/Sn | <b>T</b> =7" reeled |
| (0.102)                       | <b>X</b> =X5R                           | decimal point   | <b>D</b> =±0.5pF<br><b>F</b> =±1%                          | place of decimal point.   |                    |                     |
|                               |   | eg.:<br>0R5=0.5pF<br>1R0=1.0pF  | G=±2%<br>J=±5%<br>K=±10%                                   | <b>6R3</b> =6.3 VDC<br><b>100</b> =10 VDC<br><b>160</b> =16 VDC |                    |                     |
|                               |   | 100=10x10 <sup>0</sup><br>=10pF                                       | <b>M</b> =±20%   | <b>250</b> =25 VDC<br><b>500</b> =50 VDC                        |                    |                     |
|                               |   | OMAIN   | Chr  | CO110, 115  |                    |                     |

# **5. EXTERNAL DIMENSIONS**

| Size<br>Inch (mm) | L (mm)    | W (mm)    | T (mm)/Syr | nbol | M <sub>B</sub> (mm) |
|-------------------|-----------|-----------|------------|------|---------------------|
| 01R5 (0402)       | 0.40±0.02 | 0.20±0.02 | 0.20±0.02  | V    | 0.10±0.03           |

<sup>\*</sup> Reflow soldering only.



# **6. GENERAL ELECTRICAL DATA**

| Size                        | 01R5  |                     |                 |  |  |
|-----------------------------|---|---------------------|-----------------|--|--|
| Dielectric                  | NP0   | X7R                 | X5R             |  |  |
| Capacitance*                | 0.2pF to 220pF  | 100pF to 1000pF     | 1000pF to 0.1μF |  |  |
| Capacitance tolerance**     | Cap≤5pF:<br>A (±0.05pF), B (±0.1pF),<br>C (±0.25pF)<br>5pF <cap<10pf:<br>C (±0.25pF), D (±0.5pF)<br/>Cap≥10pF:<br/>F (±1%), G (±2%), J (±5%)</cap<10pf:<br> | K (±10%), M         | 1 (±20%)        |  |  |
| Rated voltage (WVDC)        | 16V, 25V, 50V   | _10V                | 6.3V, 10V       |  |  |
| DF / Q <sup>#1</sup>        | Cap<30pF, Q≥400+20C<br>Cap≥30pF, Q≥1000   | ≤5 %                | ≤10 %           |  |  |
| Insulation resistance at Ur | r ≥10GΩ or RxC≥500Ω*F whichever is less   |                     | RxC≥50Ω*F       |  |  |
| Operating temperature       | -55 to +125℃ SYST   | EM ALLIA55 to +125℃ | -55 to +85℃     |  |  |
| Capacitance change          | pacitance change ±30ppm   |                     | %               |  |  |
| Termination                 | Ni/Sn (lead-free termination)   |                     |                 |  |  |

<sup>\*</sup> Measured at 30~70% related humidity.

NP0: Apply 0.5~5Vrms, 1.0MHz±10% at the condition of 25°C ambient temperature.

X7R: Apply 1.0±0.2Vrms, 1.0kHz±10%, at 25°C ambient temperature.

X5R: Apply 0.5±0.2Vrms or 1.0±0.2Vrms <sup>#1</sup>, 1.0kHz±10%, at the condition of 25°C ambient temperature.

#1: Please refer to "RELIABILITY TEST CONDITIONS AND REQUIREMENTS" for detail

<sup>\*\*</sup> Preconditioning for Class II MLCC: Perform a heat treatment at 150±10°C for 1 hour, then leave in a mbient condition for 24±2 hours before measurement.

# 7. CAPACITANCE RANGE

| SIZE        |                          |     | 01R5   |       |
|-------------|--------------------------|-----|--------|-------|
|             | DIELECTRIC               | NP0 |        |       |
| RATE        | ED VOLTAGE (VDC)         | 16  | 25     | 50    |
|             | 0.2pF (0R2)              | V   | V      | V     |
|             | 0.3pF (0R3)              | V   | V      | V     |
|             | 0.4pF (0R4)              | V   | V      | V     |
|             | 0.5pF (0R5)              | V   | V      | V     |
|             | 1.0pF (1R0)              | V   | V      | V     |
|             | 1.5pF (1R5)              | V   | V      | V     |
|             | 2.0pF (2R0)              | V   | V      | V     |
| _           | 3.0pF (3R0)              | V   | V      | V     |
| _           | 4.0pF (4R0)              | V   | V      | V     |
| _           | 5.0pF (5R0)              | V   | V      | V     |
| _           | 6.0pF (6R0)              | V   | V      | V     |
| -           | 7.0pF (7R0)              | V   | V      | V     |
|             | 8.0pF (8R0)              | V   | V      | V     |
| ဦ           | 9.0pF (9R0)              | V   | V      | V     |
| <u> </u>    | 10pF (100)               | V   | V      | V     |
| ac          | 12pF (120)               | V   | V      | V     |
| Capacitance | 15pF (150)               | V   | V      | V     |
| ٥           | 18pF (180)               | V   | V      | V     |
| -           | 22pF (220)               | V   | V      | V     |
| -           | 27pF (270)               |     | V      | V     |
| H           | 33pF (330)<br>39pF (390) |     | V      | V     |
| -           | 47pF (470)               | V   | V      | V. 6  |
|             | 56pF (560)               |     | V      | V.    |
|             | 68pF (680)               | V   | V      | V     |
|             | 82pF (820)               | V   | V      | V     |
|             | 100pF (101)              | V   | V.23// | VV    |
|             | 120pF (121)              | V   | VII    | 4     |
|             | 150pF (151)              | V   | V      | 地     |
|             | 400mF (404)              | 1/  | 1/     | 46719 |

| SIZE        |                   | 01R5 |
|-------------|-------------------|------|
|             | DIELECTRIC        | X7R  |
| R.A         | TED VOLTAGE (VDC) | 10   |
|             | 100pF (101)       | V    |
| Capacitance | 150pF (151)       | V    |
| itaı        | 220pF (221)       | V    |
| oac         | 330pF (331)       | V    |
| Cap         | 470pF (471)       | V    |
|             | 1,000pF (102)     | V    |

|             | SIZE               | 01R5 |    |
|-------------|--------------------|------|----|
|             | DIELECTRIC         | X5R  |    |
| R/          | ATED VOLTAGE (VDC) | 6.3  | 10 |
|             | 1,000pF (102)      | V    | V  |
|             | 1,500pF (152)      |      | V  |
|             | 2,200pF (222)      |      | V  |
|             | 3,300pF (332)      |      | V  |
| 8           | 4,700pF (472)      |      | V  |
| ם           | 6,800pF (682)      |      | V  |
| Capacitance | 0.010µF (103)      | V    | V  |
| <u>8</u>    | 0.015µF (153)      |      |    |
| Ü           | 0.022µF (223)      | V    |    |
|             | 0.033µF (333)      | V    |    |
|             | 0.047µF (473)      | V    |    |
|             | 0.068µF (683)      |      |    |
|             | 0.10µF (104)       | V    |    |

180pF (181) 220pF (221)

# 8. PACKAGING DIMENSION AND QUANTITY

| Sing        | Thickness (mm)/Symbol |   | Paper tape |          |
|-------------|-----------------------|---|------------|----------|
| Size        |                       |   | 7" reel    | 13" reel |
| 01R5 (0402) | 0.20±0.02             | V | 20,000     | -        |

Unit: pieces

<sup>1.</sup> The letter in cell is expressed the symbol of product thickness.

<sup>2.</sup> For more information about products with special capacitance or other data, please contact WTC local representative.



Approval Sheet

# 9. RELIABILITY TEST CONDITIONS AND REQUIREMENTS

| No. | Item          | Test Condition  | Requirements   |
|-----|---------------|---|--|
| 1.  | Visual and    |   | * No remarkable defect.  |
|     | Mechanical    |   | * Dimensions to conform to individual specification sheet.   |
| 2.  | Capacitance   | *Test temp.: Room Temperature.  | * Shall not exceed the limits given in the detailed spec.  |
| 3.  | Q/ D.F.       | Class I: NP0  | * NP0: Cap≥30pF, Q≥1000; Cap<30pF, Q≥400+20C   |
|     | (Dissipation  | Cap≤1000pF, 0.5~5Vrms, 1MHz±10%   | X7R: ≤5.0 %  |
|     | Factor)       | Cap>1000pF, 1.0±0.2Vrms, 1KHz±10%<br>Class II:  | X5R: ≤10 %   |
|     |               | * 1.0±0.2Vrms, 1KHz±10%:  |  |
|     |               | X7R & X5R(≥10V) & 01R5X103≤6.3V & 01R5X104≤10V  |  |
|     |               | * 0.5±0.2Vrms, 1kHz±10%:  |  |
|     |               | X5R(≤6.3V); Excluding 01R5X103≤6.3V & 01R5X104≤10V  |  |
|     |               | * Before initial measurement (Class II only): To apply de-aging at 150℃ for 1hr then set for 24±2 hrs at room temp. |  |
| 4.  | Dielectric    | * To apply voltage (<100V) 250%.  | * No evidence of damage or flash over during test.   |
|     | Strength      | * Duration: 1 to 5 sec.   | and the same of th |
|     |               | * Charge and discharge current less than 50mA.  |  |
| 5.  | Insulation    | *Test temp.: Room Temperature.  | * NP0, X7R: ≥10GΩ or RxC≥500Ω-F whichever is smaller.  |
|     | Resistance    | *To apply rated voltage for max. 120 sec.   | X5R: RxC≥50Ω-F   |
|     |               |   |  |
|     |               |   |  |
| 6.  | Temperature   | With no electrical load.  |  |
|     | Coefficient   | T.C. Operating Temp   | T.C. Capacitance Change  |
|     |               | NPO -55~125°C at 25°C   | NPO Within ±30ppm/℃  |
|     |               | X7R -55~125℃ at 25℃   | X7R Within ±15%  |
|     |               | X5R  -55~ 85°C at 25°C  <br>*Before initial measurement (Class II only):  | X5R Within ±15%  |
|     |               | To apply de-aging at 150°C for 1hr then set for 24±2 hrs at   | $\nabla$   |
|     |               | room temp.  |  |
|     |               | *Measurement voltage for Class II   |  |
|     |               | Cap≤0.01μF: 0.5V  | IANCE C  |
|     |               | 22  | 65   |
| 7.  | Adhesive      | * Pressurizing force: 1N  | * No remarkable damage or removal of the terminations.   |
|     | Strength of   | * Test time: 10±1 sec.  | 6.5  |
|     | Termination   | My Con  | 00 00 m  |
| 8.  | Vibration     | * Vibration frequency: 10~55 Hz/min.  | * No remarkable damage.  |
|     | Resistance    | * Total amplitude: 1.5mm  | * Cap change and Q/D.F.: To meet initial spec.   |
|     |               | * Test time: 6 hrs. (Two hrs each in three mutually perpendicular directions.)                                      |  |
|     |               | * Before initial measurement (Class II only):   |  |
|     |               | To apply de-aging at 150℃ for 1hr then set for 24±2 hrs at  |  |
|     |               | room temp.  |  |
|     |               | * Cap./DF(Q) Measurement to be made after de-aging at 150°C for 1hr then set for 24±2 hrs at room temp.             |  |
| 9.  | Solderability | * Solder temperature: 235±5°C   | 95% min. coverage of all metalized area.   |
|     | _             | * Dipping time: 2±0.5 sec.  | -  |
| 10. | Bending Test  | * The middle part of substrate shall be pressurized by means  | * No remarkable damage.  |
|     |               | of the pressurizing rod at a rate of about 1 mm per second until  | :  |
|     |               | the deflection becomes 1 mm and then the pressure shall be maintained for 5±1 sec.                                  | NP0: within ±5.0% or ±0.5pF whichever is larger.  X7R: within ±12.5%   |
|     |               | * Before initial measurement (Class II only):   | X5R: within ±25.0%   |
|     |               | To apply de-aging at 150℃ for 1hr then set for 24± 2 hrs at   | (This capacitance change means the change of capacitance under   |
|     |               | room temp.  | specified flexure of substrate from the capacitance measured before  |
|     |               | * Measurement to be made after keeping at room temp. for 24±2 hrs.  | the test.)   |
|     | l             | Z4IZ 1110.  | l .  |

<sup>\* &</sup>quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 25 to 75%, Atmospheric pressure: 86 to 106kPa.

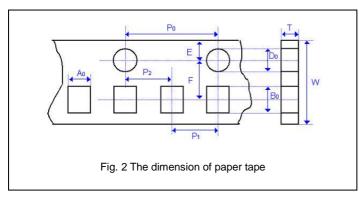
# **Multilayer Ceramic Capacitors**

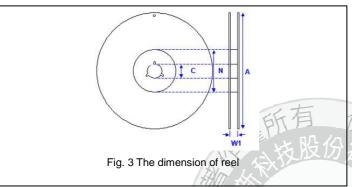
| No. | Item   | Test Condition   | Requirements  |  |
|-----|--|--|---|--|
| 11. | Resistance to<br>Soldering Heat                            | * Solder temperature: 260±5°C  * Dipping time: 10±1 sec  * Preheating: 120 to 150°C for 1 minute before immerse the capacitor in a eutectic solder.  * Before initial measurement (Class II only): To apply de-aging at 150°C for 1hr then set for 24±2 hrs at room temp.  * Cap. / DF(Q) / I.R. Measurement to be made after de-aging at 150°C for 1hr then set for 24±2 hrs at room temp.  | * No remarkable damage.  * Cap change:  NP0: within ±2.5% or ±0.25pF whichever is larger.  X7R: within ±7.5%  X5R: within ±15.0%  Q/D.F., I.R. and dielectric strength: To meet initial requirements.  * 25% max. leaching on each edge.  |  |
| 12. | Temperature<br>Cycle                                       | * Conduct the five cycles according to the temperatures and time.    Step   Temp. (°C)   Time (min.)     1   Min. operating temp. +0/-3   30±3     2   Room temp.   2~3     3   Max. operating temp. +3/-0   30±3     4   Room temp.   2~3     * Before initial measurement (Class II only): To apply de-aging at 150°C for 1hr then set for 24±2 hrs at room temp .  * Cap. / DF(Q) / I.R. Measurement to be made after de-aging  | No remarkable damage.  * Cap change: NP0: within ±2.5% or ±0.25pF whichever is larger. X7R: within ±7.5% X5R: within ±15.0%  * Q/D.F., I.R. and dielectric strength: To meet initial requirements.  |  |
|     | Humidity<br>(Steady State)<br>Humidity Load<br>(Damp Heat) | at 150°C for 1hr then set for 24±2 hrs at room temp.  * Test temp.: 40±2°C  * Humidity: 90~95% RH  * Test time: 500+24/-0hrs.  * Before initial measurement (Class II only): To apply de-aging at 150°C for 1hr then set for 24±2 hrs at room temp.  * Cap. / DF(Q) / I.R. Measurement to be made after de-aging at 150°C for 1hr then set for 24±2 hrs at room temp.  * Test temp.: 40±2°C  * Humidity: 90~95%RH  * Test time: 500+24/-0 hrs.  * To apply voltage: rated voltage.  * Before initial measurement (Class II only): To apply de-aging at 150°C for 1hr then set for 24±2 hrs at room temp. | * No remarkable damage.  * Cap change: NP0: within ±5.0% or ±0.5pF whichever is larger. X7R: within ±12.5% X5R: within ±25.0%  * O/D.F. value: NP0: Cap≥30pF, Q≥350; 10pF≤Cap<30pF, Q≥275+2.5C Cap<10pF; Q≥200+10C X7R: ≤7.5% X5R: ≤20%  * I.R.: NP0, X7R: ≥1GΩ or RxC≥50Ω-F whichever is smaller. X5R: RxC≥10Ω-F.  * No remarkable damage.  * Cap change: NP0: within ±7.5% or ±0.75pF whichever is larger. X7R: within ±15.0% X5R: within ±25.0%  * O/D.F. value: |  |
| 15. | High<br>Temperature<br>Load<br>(Endurance)                 | * Test temp.:  NP0, X7R: 125±3°C  X5R: 85±3°C  * To apply voltage: (1) NP0, X7R: 200% of rated voltage (2) X5R: 10V: 150 % of rated voltage 6.3V: 100 % of rated voltage * Test time: 1000+24/-0 hrs. * Before initial measurement (Class II only): To apply de-aging at 150°C for 1hr then set for 24±2 hrs at room temp. * Cap. / DF(Q) / I.R. Measurement to be made after de-aging at 150°C for 1hr then set for 24±2 hrs at room temp. ** De-rating conditions:   | NP0; Cap≥30pF, Q≥200; Cap<30pF; Q≥100+10/3C X7R: ≤7.5% X5R: ≤20%  * I.R.: NP0, X7R: ≥500MΩ or RxC≥25Ω-F whichever is smaller. X5R: RxC≥5Ω-F.  * No remarkable damage. * Cap change: NP0: within ±3.0% or ±0.3pF whichever is larger. X7R: within ±12.5% X5R: within ±25.0%  * N/D.F. value: NP0: Cap≥30pF, Q≥350; 10pF≤Cap<30pF, Q≥275+2.5C Cap<10pF; Q≥200+10C X7R: ≤7.5% X5R: ≤20%  * I.R.: NP0, X7R: ≥1GΩ or RxC≥50Ω-F whichever is smaller. X5R: RxC≥10Ω-F.     |  |

<sup>\* &</sup>quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 25 to 75%, Atmospheric pressure: 86 to 106kPa.

# <u>APPENDIXES</u>

# **■ Tape & reel dimensions**



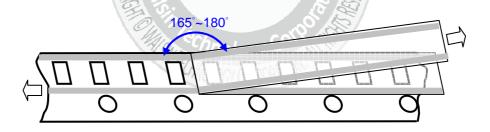


| Size              | 01R5             |
|-------------------|------------------|
| Thickness         | V                |
| A <sub>0</sub>    | 0.25<br>+/-0.05  |
| B <sub>0</sub>    | 0.45<br>+/-0.05  |
| Т                 | ≦0.50            |
| K <sub>0</sub>    | -                |
| w                 | 8.00<br>+/-0.30  |
| P <sub>0</sub>    | 4.00<br>+/-0.10  |
| 10xP <sub>0</sub> | 40.00<br>+/-0.10 |
| P <sub>1</sub>    | 2.00<br>+/-0.05  |
| P <sub>2</sub>    | 2.00<br>+/-0.05  |
| $D_0$             | 1.50<br>+0.1/-0  |
| D <sub>1</sub>    | -                |
| E                 | 1.75<br>+/-0.10  |
| F                 | 3.50<br>+/-0.05  |

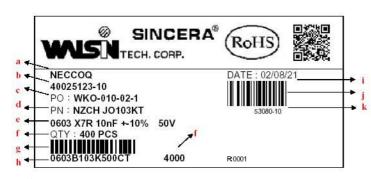
| Size      | 01R5        |
|-----------|-------------|
| Reel size | 7"          |
| C         | 13.0±0.5    |
| $W_1$     | 10.0±1.5    |
| /A        | 178.0±2.0   |
| N         | 60.0+1.0/-0 |

# **■** Peeling force (EIA-481)

Peel-off force should be in the range of 10 grams to 100 grams at a peel-off speed of 300±10 mm/min.



# **■** Example of customer label

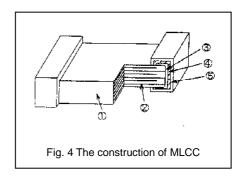


<sup>\*</sup>Customized label is available upon request

- a. Customer name
- b. WTC order series and item number
- c. Customer P/O
- d. Customer P/N
- e. Description of product
- f. Quantity
- g. Bar code including quantity & WTC P/N or customer
- h. WTC P/N
- i. Shipping date
- j. Order bar code including series and item numbers
- k. Serial number of label

### Constructions

| No. | Name             |              | NP0          | X7R, X5R                 |
|-----|------------------|--------------|--------------|--------------------------|
| 1   | Ceramic material |              | CaZrO₃ based | BaTiO <sub>3</sub> based |
| 2   | Inner electrode  |              | Ni           |                          |
| 3   |                  | Inner layer  | С            | u                        |
| 4   | Termination      | Middle layer | Ni           |                          |
| (5) |                  | Outer layer  | Sn (Matt)    |                          |



# Storage and handling conditions

- (1) To store products at 5 to 40°C ambient temperature and 20 to 70%. related humidity conditions; MSL Level 1.
- (2) The product is recommended to be used within one year after shipment. Check solderability in case of shelf life extension is needed.

#### Cautions:

- a. The corrosive gas reacts on the terminal electrodes of capacitors, and results in the poor solderability. Do not store the capacitors in the ambience of corrosive gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine, ammonia gas etc.)
- In corrosive atmosphere, solderability might be degraded, and silver migration might occur to cause low reliability.
- c. Due to the dewing by rapid humidity change, or the photochemical change of the terminal electrode by direct sunlight, the solderability and electrical performance may deteriorate. Do not store capacitors under direct sunlight or dewing condition. To store products on the shelf and avoid exposure to moisture.

PASSIVE SYSTEM ALLIANCE

# Recommended soldering conditions

The lead-free termination MLCCs are not only to be used on SMT against lead-free solder paste, but also suitable against lead-containing solder paste. If the optimized solder joint is requested, increasing soldering time, temperature and concentration of N<sub>2</sub> within oven are recommended.

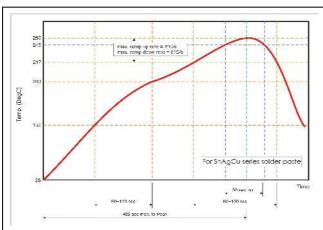


Fig. 5 Recommended reflow soldering profile for SMT process with SnAgCu series solder paste.